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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,513,431 A	07-1950	SELL FRANCIS M	219/68
*	B	US-2,643,463 A	06-1953	GRANTHAM FREDERICK W	34/546
*	C	US-3,031,772 A	05-1962	SASNETT RUSSELL M	34/82
*	D	US-3,261,389 A	07-1966	MILAN MOMCHILOVICH et al.	431/77
*	E	US-3,287,817 A	11-1966	SMITH THOMAS R	34/446
*	F	US-3,508,850 A	04-1970	GOOD ARTHUR L	431/2
*	G	US-3,691,097 A	09-1972	Stiles et al.	502/63
*	H	US-4,206,552 A	06-1980	Pomerantz et al.	34/445
*	I	US-4,245,146 A	01-1981	Shioi et al.	219/553
*	J	US-4,260,872 A	04-1981	Brodmann et al.	219/270
*	K	US-4,298,789 A	11-1981	Eichelberger et al.	219/406
*	L	US-4,622,759 A	11-1986	Abe et al.	34/546
*	M	US-4,656,455 A	04-1987	Tanino et al.	338/35

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06170096 A	06-1994	Japan	NAKAURA et al.	D06F 58/28
	O					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/539,453 DITTMER ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,172,490 A	12-1992	Tatsumi et al.	34/488
*	B	US-5,301,438 A	04-1994	Tanaka et al.	34/550
*	C	US-5,355,425 A	10-1994	Braiman et al.	385/31
*	D	US-5,367,265 A	11-1994	Gaudette, Marvin F.	307/650
*	E	US-5,454,171 A	10-1995	Ikeda et al.	34/492
*	F	US-5,567,144 A	10-1996	McCoy, Hugh W.	431/79
*	G	US-5,768,730 A	06-1998	Matsumoto et al.	8/159
*	H	US-5,887,456 A	03-1999	Tanigawa et al.	68/20
*	I	US-6,020,698 A	02-2000	Stenger et al.	318/162
*	J	US-6,032,494 A	03-2000	Tanigawa et al.	68/12.06
*	K	US-2002/0096984 A1	07-2002	Konishi et al.	313/25
*	L	US-2003/0050220 A1	03-2003	Trinh et al.	510/521
*	M	US-2003/0082972 A1	05-2003	Monfalcone et al.	442/138

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,589,312 B1	07-2003	Snow et al.	75/255
*	B	US-6,654,549 B1	11-2003	Konishi, Masanori	392/407
*	C	US-2004/0037542 A1	02-2004	Kanishi, Masanori	392/407
*	D	US-2004/0060197 A1	04-2004	Jeong et al.	034/595
*	E	US-2004/0096202 A1	05-2004	Konishi, Masanori	392/407
*	F	US-2004/0116792 A1	06-2004	Nesbitt, Bruce	600/373
*	G	US-2004/0172985 A1	09-2004	Mamiya et al.	068/012.05
*	H	US-6,845,217 B2	01-2005	Konishi, Masanori	392/407
*	I	US-2005/0022311 A1	02-2005	Zhang et al.	008/115.51
*	J	US-2005/0050763 A1	03-2005	Park et al.	034/595
*	K	US-2005/0050758 A1	03-2005	Park et al.	034/425
*	L	US-2005/0136785 A1	06-2005	Konishi et al.	445/027
*	M	US-6,922,017 B2	07-2005	Konishi et al.	313/623

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
	R					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,931,759 B2	08-2005	Jeong et al.	34/485
*	B	US-6,941,674 B2	09-2005	Park et al.	34/88
*	C	US-2005/0278974 A1	12-2005	Chung, Young Suk	034/528
*	D	US-7,020,982 B2	04-2006	Park et al.	34/496
*	E	US-2006/0101943 A1	05-2006	Snow et al.	075/252
*	F	US-7,047,663 B2	05-2006	Zhang et al.	34/348
*	G	US-2006/0123654 A1	06-2006	Zhang et al.	034/348
*	H	US-2006/0186222 A1	08-2006	Ikemizu et al.	239/398
*	I	US-7,118,611 B2	10-2006	Snow et al.	75/255
*	J	US-7,160,297 B2	01-2007	Nesbitt, Bruce	606/45
*	K	US-7,184,656 B2	02-2007	Konishi, Masanori	392/407
*	L	US-2007/0123853 A1	05-2007	Nesbitt, Bruce	606/045
*	M	US-2007/0106294 A1	05-2007	Nesbitt, Bruce	606/045

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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NON-PATENT DOCUMENTS

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	U	
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	W	
	X	

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/539,453 DITTMER ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,267,597 B2	09-2007	Konishi et al.	445/27
*	B	US-2007/0220683 A1	09-2007	Kim, Chang Hoo	8/158
*	C	US-7,288,091 B2	10-2007	Nesbitt, Bruce	606/45
*	D	US-7,320,184 B2	01-2008	Zhang et al.	34/597
*	E	US-2008/0050509 A1	02-2008	Nesbitt, Bruce	427/002.12
*	F	US-7,390,326 B2	06-2008	Nesbitt, Bruce	606/45
*	G	US-2008/0184588 A1	08-2008	Somod et al.	34/495
*	H	US-2008/0302138 A1	12-2008	Bae et al.	68/12.05
*	I	US-2008/0299006 A1	12-2008	Ikemizu, Mugihei	422/62
*	J	US-2009/0000040 A1	01-2009	Ikemizu, Mugihei	8/158
*	K	US-2009/0061131 A1	03-2009	Monfalcone et al.	428/35.6
*	L	US-2009/0100882 A1	04-2009	Bae et al.	68/5.C
*	M	US-7,600,402 B2	10-2009	Shin et al.	68/5C

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2009/0260256 A1	10-2009	Beaulac, Sebastien	34/528
*	B	US-2009/0265953 A1	10-2009	Bae et al.	34/467
*	C	US-2009/0255299 A1	10-2009	Hiro et al.	68/19
*	D	US-7,618,684 B2	11-2009	Nesbitt, Bruce	427/470
*	E	US-2009/0288456 A1	11-2009	Bae et al.	68/5.R
*	F	US-2009/0274985 A1	11-2009	McKnight et al.	431/36
*	G	US-7,624,601 B2	12-2009	Ikemizu et al.	68/17R
*	H	US-2009/0313848 A1	12-2009	Moschutz et al.	34/549
*	I	US-2010/0000117 A1	01-2010	Choi et al.	34/443
*	J	US-2010/0000269 A1	01-2010	Shin et al.	68/5.C
*	K	US-2010/0011611 A1	01-2010	KIM et al.	34/390
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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